

<b>Notice of References Cited</b>	Application/Control No. 10/602,744	Applicant(s)/Patent Under Reexamination BAEK ET AL.
	Examiner Marissa L. Ferguson	Art Unit 2854

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,445,437	09-2002	Miyazaki et al.	349/156
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	404134401	05-1992	Japan	Kobayashi et al.	G02B 005/20
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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